

MCR12DG, MCR12MG, MCR12NG





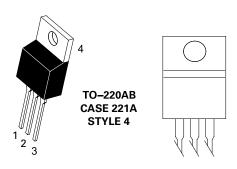
Description

Designed primarily for half-wave ac control applications, such as motor controls, heating controls and power supplies; or wherever half-wave silicon gate-controlled, solid-state devices are needed.

Features

- Blocking Voltage to 800 Volts
- On-State Current Rating of 12 Amperes RMS at 80°C
- High Surge Current Capability – 100 Amperes
- Rugged, Economical TO-220AB Package
- Glass Passivated Junctions for Reliability and Uniformity
- Minimum and Maximum Values of IGT, VGT an Specified for Ease of Design
- High Immunity to dv/dt
 100 V/sec Minimum at
 125°C
- These are Pb–Free devices

Pin Out



Functional Diagram



Additional Information







Samples



Maximum Ratings (T₁ = 25°C unless otherwise noted)

Rating	Part Number	Symbol	Value	Unit
Peak Repetitive Off-State Voltage (Note 1) (T _J = -40 to 110°C, Sine Wave, 50 to 60 Hz, Gate Open) MCR12DG MCR12MG MCR12MG MCR12NG		V _{DRM} ,	400 600 800	V
On-State RMS Current (180° Conduction Angles; T _c = 80°C)		I _{T (RMS)}	12	А
Peak Non-repetitive Surge Current (1/2 Cycle, Sine Wave 60 Hz, T _J = 125°C)			100	А
Circuit Fusing Consideration (t = 8.3 ms)			41	A ² sec
Forward Peak Gate Power (Pulse Width ≤ 1.0 µs, T _C = 80°C)			5.0	W
Forward Average Gate Power (t = 8.3 ms, T_c = 80°C)			0.5	W
Average On-State Current (180° Conduction Angles; T _c = 80°C)			7.8	А
Forward Peak Gate Current (Pulse Width $\leq 1.0 \text{ s}$, $T_c = 90^{\circ}\text{C}$)			2.0	А
Operating Junction Temperature Range	T _J	-40 to +125	°C	
Storage Temperature Range			-40 to +150	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

Thermal Characteristics

Ratin	Symbol	Value	Unit	
Thermal Resistance,	Junction-to-Case (AC) Junction-to-Ambient	R _{ejc} R _{eja}	2.2 62.5	°C/W
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds		T _L	260	°C

Electrical Characteristics - **OFF** (T_J = 25°C unless otherwise noted)

Characteristic		Symbol	Min	Тур	Max	Unit
Peak Repetitive Forward or Reverse Blocking Current	T, = 25°C	I _{DRM} ,	-	-	0.01	m ^
(VD = Rated VDRM and VRRM; Gate Open)	$T_{J}^{\circ} = 125^{\circ}C$	I _{RRM}	-	-	2.0	mA

Electrical Characteristics - ON

Characteristic	Symbol	Min	Тур	Max	Unit
Peak Forward On–State Voltage (Note 2) ($I_{TM} = 24 \text{ A}$)		-	-	1.7	V
Gate Trigger Voltage (Continuous dc) ($V_D = 12 \text{ V}, R_L = 100 \Omega$)		2.0	8.0	20	mA
Holding Current (V _D = 12 Vdc, Initiating Current = 200 mA, Gate Open)		-	18	40	mA
Latch Current ($V_D = 12 \text{ V}, I_G = 20 \text{ mA}$)		6.0	25	60	mA
Gate Trigger Voltage (Continuous dc) (V_D = 12 Vdc, R_L = 100 Ω)		0.5	0.65	1.0	V

Dynamic Characteristics

Characteristic	Symbol	Min	Тур	Max	Unit
Critical Rate-of-Rise of Off-State Voltage ($V_D = Rated V_{DRM'}$ Exponential Waveform, Gate Open, $T_J = 125$ °C)	dv/dt	100	250	_	V/µs
Repetitive Critical Rate of Rise of On–State Current IPK = 50 A, Pw = 40 µsec, diG/dt = 1 A/µsec, Igt = 50 mA	di/dt	-	-	50	A/µs

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

V_{DBM} and V_{RBM} for all types can be applied on a continuous basis. Ratings apply for zero or negative gate voltage; however, positive gate voltage shall not be applied concurrent with negative potential on the anode. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the devices are exceeded.

^{2.} Indicates Pulse Test: Pulse Width ≤ 2.0 ms, Duty Cycle ≤ 2%.



Voltage Current Characteristic of SCR

Symbol	Parameter	
V _{DRM}	Peak Repetitive Forward Off State Voltage	
I _{DRM}	Peak Forward Blocking Current	
V _{RRM}	Peak Repetitive Reverse Off State Voltage	
I _{RRM}	Peak Reverse Blocking Current	
V _{TM}	Maximum On State Voltage	
I _H	Holding Current	

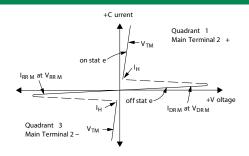


Figure 1. Typical RMS Current Derating

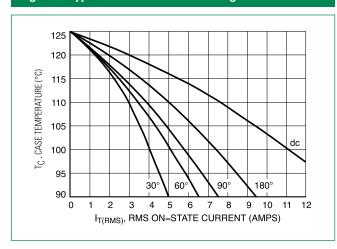


Figure 2. On-State Power Dissipation

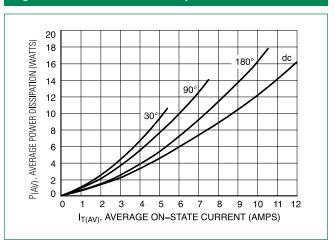


Figure 3. Typical On-State Characteristics

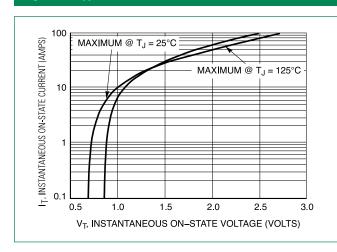


Figure 4. Typical Gate Trigger Current vs Junction Temp

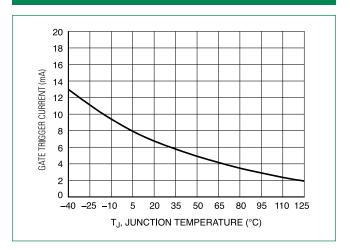




Figure 5. Typical Holding Current vs Junction Temp

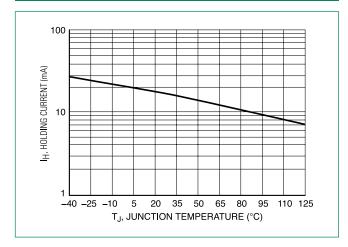


Figure 6. Typical Gate Trigger Voltage vs Junction Temp

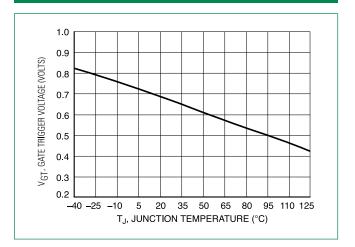
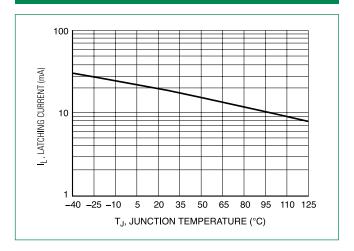
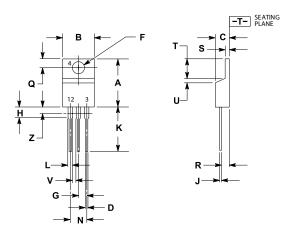


Figure 7. Typical Latching Current vs Junction Temp

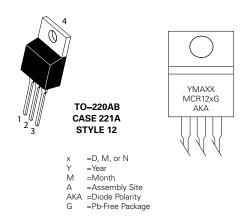




Dimensions



Part Marking System



	Inches		Inches		Millin	Millimeters		
Dim	Min	Max	Min	Max				
А	0.590	0.620	14.99	15.75				
В	0.380	0.420	9.65	10.67				
С	0.178	0.188	4.52	4.78				
D	0.025	0.035	0.64	0.89				
F	0.142	0.147	3.61	3.73				
G	0.095	0.105	2.41	2.67				
Н	0.110	0.130	2.79	3.30				
J	0.018	0.024	0.46	0.61				
K	0.540	0.575	13.72	14.61				
L	0.060	0.075	1.52	1.91				
N	0.195	0.205	4.95	5.21				
Q	0.105	0.115	2.67	2.92				
R	0.085	0.095	2.16	2.41				
S	0.045	0.060	1.14	1.52				
Т	0.235	0.255	5.97	6.47				
U	0.000	0.050	0.00	1.27				
V	0.045		1.15					
Z		0.080		2.04				

Pin Assignment			
1	Cathode		
2	Anode		
3	Gate		
4	Anode		

Ordering Information				
Device	Package	Shipping		
MCR12DG				
MCR12MG	TO-220AB (Pb-Free)	500 Units / Box		
MCR12NG	(1.2.1.00)			

- 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- 2. CONTROLLING DIMENSION: INCH.
- 3. DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.